Agilent E5071C ENA
Network Analyzer

9 kHz to 4.5/6.5/8.5 GHz
100 kHz to 4.5/6.5/8.5 GHz
(with bias tees)
300 kHz to 14/20 GHz
(with bias tees)

The industry standard in
RF network analysis

Agilent Technologies
Agilent’s E5071C ENA network analyzers deliver new standards in speed, accuracy and versatility for RF network analysis. Designed with a wide range of measurement capability to meet multiple network analysis needs, the ENA offers efficiency and flexibility for both manufacturing and R&D applications in industries such as wireless communication, automotive, semiconductor, and medical.

Key features

► Wide frequency coverage: 9 kHz to 20 GHz
► Low trace noise: < 0.004 dB rms at 70 kHz IFBW
► Wide dynamic range: > 123 dB
► Fast measurement speed: 9 msec for 401 points with error correction
► High temperature stability: 0.005 dB/°C

● 2 or 4 ports, plus flexible multiport configuration of up to 22 ports with E5092A
● Built-in VBA programming environment enables high throughput and UI customization
● Powerful analysis and error correction
● Advanced characterization of mixers (such as the vector mixer calibration) and amplifiers with frequency offset mode (optional)
● Advanced characterization of high-speed serial interconnects with enhanced time domain analysis (optional)
● Upgrade are available for all E5071C options at any time
# Flexible Test Port Architecture for a Variety of Applications

*Select the number of ports, frequency and bias tees to fit your application*

<table>
<thead>
<tr>
<th>Number of ports</th>
<th>Frequency range</th>
<th>Option numbers</th>
</tr>
</thead>
<tbody>
<tr>
<td>2-Port</td>
<td></td>
<td>E5071C-240</td>
</tr>
<tr>
<td></td>
<td></td>
<td>E5071C-245</td>
</tr>
<tr>
<td>2-Port</td>
<td></td>
<td>E5071C-260</td>
</tr>
<tr>
<td></td>
<td></td>
<td>E5071C-285</td>
</tr>
<tr>
<td></td>
<td></td>
<td>E5071C-280</td>
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<tr>
<td></td>
<td></td>
<td>E5071C-285</td>
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<tr>
<td></td>
<td></td>
<td>E5071C-265</td>
</tr>
<tr>
<td></td>
<td></td>
<td>E5071C-255</td>
</tr>
<tr>
<td>4-Port</td>
<td></td>
<td>E5071C-440</td>
</tr>
<tr>
<td></td>
<td></td>
<td>E5071C-445</td>
</tr>
<tr>
<td></td>
<td></td>
<td>E5071C-460</td>
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<tr>
<td></td>
<td></td>
<td>E5071C-465</td>
</tr>
<tr>
<td></td>
<td></td>
<td>E5071C-480</td>
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<tr>
<td></td>
<td></td>
<td>E5071C-485</td>
</tr>
<tr>
<td></td>
<td></td>
<td>E5071C-4D5</td>
</tr>
<tr>
<td></td>
<td></td>
<td>E5071C-4K5</td>
</tr>
<tr>
<td>22-Port</td>
<td></td>
<td>E5071C-440 or -445</td>
</tr>
<tr>
<td></td>
<td></td>
<td>E5071C-460 or -465</td>
</tr>
<tr>
<td></td>
<td></td>
<td>E5071C-480 or -485</td>
</tr>
<tr>
<td></td>
<td></td>
<td>E5071C-4D5</td>
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<tr>
<td></td>
<td></td>
<td>E5071C-4K5</td>
</tr>
</tbody>
</table>

### Frequency range

- 9 kHz
- 100 kHz
- 300 kHz
- 50 MHz
- 4.5 GHz
- 6.5 GHz
- 8.5 GHz
- 14 GHz
- 20 GHz

*with bias tees*
Enhanced Usability Increases Efficiency in R&D & Manufacturing

Providing the latest in modern technology, Agilent ENA network analyzers provide the performance and features needed in R&D and manufacturing for a wide range of applications.

- Class largest (10.4 inches) XGA color LCD with touch screen
- 160 measurement channels and 16 measurement traces
- Intuitive user interface: hard keys, soft keys, and pull-down menus
- Removable HDD for secure environments (optional)
- Windows® Operating system
- Dual probe power source
- Context sensitive embedded help

The ENA’s intuitive user interface lets you easily set up complex measurements and quickly retrieve measurement data.
ENA – New Standards in Speed and Accuracy

Agilent’s new generation of network analyzers meets and exceeds what was possible with the 8753 family. Carrying on the family tradition, the ENA delivers new standards in speed, accuracy and versatility for RF network analysis.

**Wide dynamic range**

>123 dB dynamic range provides more precise evaluation of high rejection filters.

Dynamic range comparison: IFBW = 10Hz

**Low trace noise**

<0.004 dB rms at 70 kHz IFBW helps minimize errors when measuring high-quality, low loss devices.

Trace noise comparison: IFBW = 1 kHz

**High stability**

4 times better long-term temperature stability than the 8753ES for more confident evaluations.

Stability versus temperature

**Fast measurement speed**

More than 20 times faster than the 8753ES to increase your throughput and lower your cost per component.

Measurement speed comparison:
1601 pts, Full-2 port cal, 1 GHz to 1.2 GHz
IFBW = 6 kHz (8753ES), 500 kHz (E5071C)

<table>
<thead>
<tr>
<th>Model</th>
<th>Stability (dB/°C)</th>
<th>Measurement Speed (msec)</th>
</tr>
</thead>
<tbody>
<tr>
<td>E5071C</td>
<td>0.005</td>
<td>41</td>
</tr>
<tr>
<td>8753ES</td>
<td>0.02</td>
<td>848</td>
</tr>
</tbody>
</table>
Enhanced Measurement Capability for a Variety of Applications

The Agilent E5071C ENA combines the highest RF performance with powerful analysis capabilities and automated test tools that increase test efficiency and yield.

**Powerful analysis capabilities**

- Fixture simulator for
  - Mixed-mode S-parameter measurements\(^1\)
  - Embedding and de-embedding
  - Matching circuit simulation
  - Port impedance conversion
- Equation editor for real-time data processing
- Time-domain analysis (optional)
- Enhanced time domain analysis (optional)
- Absolute value measurement
- 75 Ω measurement with a minimum loss pad
- Modeling devices with Agilent Advanced Design System (ADS) and IC-CAP
- Dielectric and magnetic properties measurement with Agilent materials measurement software

**State-of-art calibration techniques**

- Up to full 4-port SOLT, TRL, or unknown thru calibration
- Automatic port extension
- Adapter removal or insertion
- ECal module with various connector types or user-characterized ECal for use with any adapter
- Scalar mixer calibration and patented vector mixer calibration\(^2\)

**Test automation tools**

- Easy-to-use built-in VBA programming environment for fast post data processing
- Measurement Wizard Assistant (MWA) software for multiport measurement system (optional)
- Pre-defined limit test functions for pass/fail testing in production

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1. 4-port option required.
2. E5071C-008 frequency offset mode required.
Accurate and efficient component design and verification

Circuits

With a combination of speed, accuracy, and advanced functionality, the ENA provides powerful general-purpose network analysis. The ENA offers extensive measurement capabilities, analysis features, and post data processing capabilities for effective design characterization.

The ENA has real-time fixture simulation capability, which lets you specify components as they are used in actual circuits. Bundled VBA macros and analysis functions enable fast, easy post data processing. Measured data is easily shared with EDA tools, such as Agilent’s Advanced Design System (ADS). This enables you to quickly link measurement results back to your simulations to improve your designs and accelerate design verification.

Industry-leading RF performance

Design high-performance products with confidence.

- State-of-the-art calibration techniques for the highest measurement accuracy
- Automatic port extension for in-fixture devices
- Fixture simulator for embedding or de-embedding user-defined circuits

Accelerate design verification

Simplify complicated measurement procedures and reduce your test program development time.

- Free sample programs on the Agilent Web site
- Equation editor for real-time data processing
- Powerful connectivity with Windows OS; USB, LAN, GPIB, and a Web based remote user interface

Completely upgradeable at any time

Keep up with rapidly changing device requirements and parameters.

- Upgrade to current E5071C hardware or software options at any time
Industry-leading RF performance for the highest throughput and yield

Passive components
The ENA is ideal for high-volume passive component test. Superior measurement performance contributes the highest throughput increasing your production capability. High repeatability and stability improve test yield.

Best-in-class RF performance

*Increase test throughput and reduce the overall cost of test.*

- Fast measurement speed
- Built-in VBA for easy automation and fast data processing
- Pre-defined limit test functions to meet your test requirements
- Segment sweep function to optimize stimulus setting
- ECal for reduced calibration times

High repeatability increases test yields

*Improve test yields with superior measurement performance.*

- Low trace noise
- Wide dynamic range
- High temperature stability

Easy, accurate in-fixture calibration

*Reduce measurement errors.*

- 4-port TRL calibration for multiport calibration
- Automatic port extension (APE) for easy calibration
- Adapter removal/insertion for accurate mixed-connector calibration

Application note: Evolution of Test Automation Using the Built-In VBA with the ENA Series RF Network Analyzers, 
Basic and advanced measurement utilities enable thorough device characterization

**Amplifiers**

RF amplifiers are used in a wide variety of industries. Whether characterizing the amplifier performance for wireless communication systems, medical equipment or automotive use, their characterization is always a significant stage in the design and verification process of complete systems.

The ENA features the basic measurement fundamentals for P1dB, PAE or K-factor as well as advanced techniques and built-in functions that simplify the total characterization of your amplifiers.

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**Advanced measurement utilities**

Simplify the total characterization of your amplifiers with built-in functions.

- DC voltage measurement capability
- Built-in bias tee option
- External test set mode for high-power measurements
- Trigger lines for complicated testing

**Powerful data processing**

Quickly and easily process post measurement data.

- Amplifier measurement wizard program
- Equation editor for user-defined parameters

**Easy software connectivity**

Quickly link measurement results back to your simulations.

- Intuilion software
- ADS link with Advanced Design System software

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State-of-the-art measurement capability

Mixers and converters

Frequency converting devices such as mixers are used in many applications. These components require unique measurement techniques because they have different frequencies at the input and output ports.

The ENA offers several measurement methods for accurate characterization of these devices. Advanced calibration methods including Agilent patented vector mixer calibration (VMC) provide more accurate measurement results of your devices than conventional calibration methods.

Powerful built-in software functions

*Reduce setup and measurement times.*

- Frequency offset mode (FOM) option
- Balanced mixer measurement
- Absolute group delay measurement

Easy-to-use analysis software

*Reduce your operating time.*

- Mixer measurement wizard program
- Vector mixer characterization program

State-of-the-art calibration

*Accurately characterize frequency converting devices.*

- Power and receiver calibration
- Scalar mixer calibration (SMC) for match corrected amplitude measurement
- Vector mixer calibration (VMC) for single-ended and balanced mixer measurement

Expand your measurement capability with the ENA multiport solution

**Multiport devices**

Today’s devices often have multiple functionality integrated into a single component resulting in multiple RF ports. For multiport network analysis, measurement setup time is usually much longer than the actual testing time.

When the ENA is combined with the E5092A configurable multiport test set, they form comprehensive multiport solution. The ENA’s Measurement Wizard Assistant (MWA) software simplifies complicated measurement procedures for multiport characterization.

**Flexible multiport configuration**

Meet the increasing, changing demands of multiport devices.

- E5092A configurable multiport test set
- Up to 10-port full crossbar measurement
- Up to 22-port measurement capability

**Significantly reduce test setup times**

Simplify complicated multiport measurements with Measurement Wizard Assistant software.

- Step-by-setup wizard for file setup
- Automatic parameter setup for the ENA
- Calibration wizard
- Detailed analysis of the measurement results

**Easily expand up to 40 ports**

Meet future demands with expandable multiport capability.

- Cascade two E5092As for more ports
  - Up to 16-port full crossbar measurement
  - Up to 40-port measurement capability


Evaluate performance under actual working conditions

**EMC components**

Electro-magnetic compatibility (EMC) is a key specification in broadband wireless communication and automotive electronics, where EMC components play an important role in meeting strict standard requirements. The ENA’s powerful analysis functions help you determine the true performance of your product under the actual working conditions.

**DC-biased measurement setup**

**Broad operating frequency coverage**

*Evaluate a wide range of applications.*

- Down to 9 kHz/100 kHz (with bias tees)
- Upgradeable to higher frequency

**Easy-to-use assistant programs**

1. **Evaluate EMC components under actual bias conditions VBA sample program.**
   - Impedance format display with bias current control function
   - External DC source control via GPIB1/USB or LAN interface

2. **Display MaxHOLD trace VBA sample program**
   - Both GUI and remote control functions are available
   - Useful for the EMC site evaluation and the site VSWR measurement. (eg. CISPR16-1-4)

**Powerful balance measurement analysis**

*Reduce the complexity of measurements for balanced components.*

- 4-port embedding/de-embedding to remove unwanted fixture effects or to simulate circuit effects
- Impedance value display
- Common mode rejection ratio (CMRR) measurement


1. Agilent 82357B USB-GPIB interface is necessary.
2. Display the maximum of any given active measurement. The held trace is displayed as a memory trace.
Obtain confidence in design through complete characterization of high-speed serial interconnects

High-speed serial interconnects
As bit rates of digital systems increase, signal integrity of interconnects drastically affects system performance. Fast and accurate analysis of interconnect performance in both time and frequency domains become critical to ensure reliable system performance.

Because managing multiple test systems becomes difficult, a single test system that can fully characterize differential high speed digital devices is a very powerful tool.

The Enhanced time domain analysis option provides an one box solution for high speed interconnect analysis, enabling time domain, frequency domain, and eye diagram analysis.

The Enhanced time domain analysis option provides the following three breakthroughs for signal integrity design and verification:

- Simple and Intuitive Operation
- Fast and Accurate Measurements
- ESD Robustness

Simple and Intuitive Operation

TDR oscilloscope look-and-feel.

- Dedicated controls for common adjustments
- Automatic display allocation for most common measurement parameters
- The Setup Wizard guides the user through all the required steps, making setup, error correction, and measurement intuitive and error free

ESD Robustness

Protection circuits implemented inside the instrument.

- Proprietary electrostatic discharge (ESD) protection chip to significantly increase ESD robustness, while at the same time maintaining excellent RF performance

Fast and Accurate Measurements

Delivers new standards in speed, accuracy, and versatility.

- Wide dynamic range to observe the true performance of your device
- Low noise floor for accurate and repeatable measurements
- Fast measurement speed for real-time analysis
- State-of-the-art calibration techniques to reduce measurement errors

For additional information regarding the Enhanced time domain analysis option, visit: www.agilent.com/find/ena-tdr
Accurate, easy-to-use solution for on wafer test

On-wafer measurements

For successful evaluation of on-wafer semiconductor or RF MEMS devices, the total accuracy of your measurement system and easy operation are crucial. The ENA offers state-of-the-art features for accurate measurements and compatibility with many probe systems.

On-wafer measurements

A complete solution for your on-wafer measurements.

▼ Accurate calibration at probe tips
▼ Supported by IC-CAP and ADS connection manager
▼ Supported by popular on-wafer calibration software
▼ Two GSGSG probe contacts using a 4-port test set

For additional information regarding Cascade Microtech, visit: www.cascademicrotech.com

Simplify material evaluation

Material measurements

Simplify your material test in the RF range by combining the ENA with ready-to-use Agilent Materials software and probe kits. The ENA's highly-accurate measurements will help you determine the highest performing materials for your application, shortening your design time.

Dielectric Constant

Measure the dielectric characteristics over a wide frequency range.
▼ Supported by 85071E Material Measurement software and the 85070E probe system

For additional information regarding material software, visit: www.agilent.com/find/materials

Application Note: 85070E Dielectric Probe Kit
# Key specifications

<table>
<thead>
<tr>
<th></th>
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<th></th>
<th></th>
<th></th>
<th></th>
<th></th>
</tr>
</thead>
<tbody>
<tr>
<td>Test frequency</td>
<td>9 or 100 kHz to 4.5 GHz</td>
<td>9 or 100 kHz to 6.5 GHz</td>
<td>9 or 100 kHz to 8.5 GHz</td>
<td>300 kHz to 14 GHz</td>
<td>300 kHz to 20 GHz</td>
<td>30 kHz to 6 GHz</td>
</tr>
<tr>
<td>Source power range 1</td>
<td>–55 dBm to +10 dBm</td>
<td>–85 dBm to +10 dBm</td>
<td>–85 dBm to +10 dBm</td>
<td>–85 dBm to +10 dBm</td>
<td>–85 dBm to +10 dBm</td>
<td>–85 dBm to +10 dBm</td>
</tr>
<tr>
<td>Dynamic range</td>
<td>&gt;123 dB</td>
<td></td>
<td></td>
<td>110 dB</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Trace noise</td>
<td>&lt; 0.004 dB</td>
<td></td>
<td></td>
<td>0.006 dBms</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Measurement speed 2</td>
<td>41 ms</td>
<td></td>
<td></td>
<td>848 ms</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Stability</td>
<td>0.005 dB/degree C</td>
<td></td>
<td></td>
<td>0.02 dB/degree C</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Interface</td>
<td>GPIB/LAN/USB</td>
<td>GPIB</td>
<td>GPIB</td>
<td>GPIB</td>
<td>GPIB</td>
<td>GPIB</td>
</tr>
<tr>
<td>Test port</td>
<td>2- or 4-port</td>
<td>2- or 3-port</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Max number of points</td>
<td>20,001</td>
<td>1,601</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Max number of channels</td>
<td>160</td>
<td>2</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Calibration</td>
<td>SOLT, TRL, Adapter removal/insertion, Unknown thru, ECAL, User characterized ECal, SMC, VMC</td>
<td>SOLT, TRL 3, Adapter Removal</td>
<td>SOLT, TRL 3, Adapter Removal</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Web-enabled control</td>
<td>Yes</td>
<td>No</td>
<td>No</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Fixture simulator</td>
<td>Yes</td>
<td>No</td>
<td>No</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Built-in programming environment</td>
<td>VBA</td>
<td>No</td>
<td>No</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Future enhancements /upgradeable</td>
<td>Yes</td>
<td>No</td>
<td>No</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Filter tuning limit lines</td>
<td>Yes</td>
<td>Yes</td>
<td>Yes</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Built-in bias tees</td>
<td>Yes</td>
<td>Yes</td>
<td>Yes</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Probe power</td>
<td>Yes</td>
<td>Yes</td>
<td>Yes</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>DC measurements</td>
<td>Yes</td>
<td>Yes</td>
<td>Yes</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Frequency offset mode option</td>
<td>Yes</td>
<td>Yes</td>
<td>Yes</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Time-domain option</td>
<td>Yes</td>
<td>Yes</td>
<td>Yes</td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

1. Maximum output power is changed according to measurement frequency.
2. 1601 points, Full two-port calibration, 1 GHz to 1.2 GHz, IFBW = 500 kHz (E5071C), 6 kHz (8753ES).
3. For more detail, refer to Application Note: 7 Reasons to Upgrade from your 8753 to an ENA Network Analyzer, AN 1478, 5989-0206EN http://cp.literature.agilent.com/litweb/pdf/5989-0206EN.pdf

For more details, refer to the ENA E5071C Network Analyzer Data Sheet, 5989-5479EN http://cp.literature.agilent.com/litweb/pdf/5989-5479EN.pdf
Secure your assets

Protecting your 8753 software investment
The E5071C has a 8753 code compatible mode in which the analyzer automatically translates the 8753’s remote programming commands for operation on the E5071C. This enables you drop-in replacement in the automated test environment.¹

Protecting your hardware investment
The E5071C is a safe investment because of its flexibility. You can easily upgrade any feature of the E5071C whenever you need the feature! This includes not only software options like time-domain mode, frequency offset mode, and MWA, but also hardware option such as frequency, test-port and high stability.

¹ Contact your Agilent sales representatives for technical support.
### Ordering information

**E5071C ENA network analyzer**

- **Option E5071C-240** 2-port test set, 9 kHz to 4.5 GHz  
  *without bias tees*

- **Option E5071C-245** 2-port test set, 100 kHz to 4.5 GHz  
  *with bias tees*

- **Option E5071C-440** 4-port test set, 9 kHz to 4.5 GHz  
  *without bias tees*

- **Option E5071C-445** 4-port test set, 100 kHz to 4.5 GHz  
  *with bias tees*

- **Option E5071C-260** 2-port test set, 9 kHz to 6.5 GHz  
  *without bias tees*

- **Option E5071C-265** 2-port test set, 100 kHz to 6.5 GHz  
  *with bias tees*

- **Option E5071C-460** 4-port test set, 9 kHz to 6.5 GHz  
  *without bias tees*

- **Option E5071C-465** 4-port test set, 100 kHz to 6.5 GHz  
  *with bias tees*

- **Option E5071C-280** 2-port test set, 9 kHz to 8.5 GHz  
  *without bias tees*

- **Option E5071C-285** 2-port test set, 100 kHz to 8.5 GHz  
  *with bias tees*

- **Option E5071C-480** 4-port test set, 9 kHz to 8.5 GHz  
  *without bias tees*

- **Option E5071C-485** 4-port test set, 100 kHz to 8.5 GHz  
  *with bias tees*

- **Option E5071C-2D5** 2-port test set, 300 kHz to 14 GHz  
  *with bias tees*

- **Option E5071C-4D5** 4-port test set, 300 kHz to 14 GHz  
  *with bias tees*

- **Option E5071C-2K5** 2-port test set, 300 kHz to 20 GHz  
  *with bias tees*

- **Option E5071C-4K5** 4-port test set, 300 kHz to 20 GHz  
  *with bias tees*

**Additional Options**

- **Option E5071C-008** Frequency offset mode

- **Option E5071C-TDR** Enhanced time domain analysis

- **Option E5071C-010** Time domain analysis

- **Option E5071C-790** Measurement Wizard Assistant software

- **Option E5071C-1E5** High stability timebase

- **Option E5071C-017** Removable hard disk drive

**E5092A Configurable multiport test set**

- **Option E5092A 020** 20 GHz, up to 22-port configurable multiport test set

For details, refer to the ENA Network Analyzer Configuration Guide,  

### Web resources

available on the ENA Web site: www.agilent.com/find/ena

Visit our Web sites for additional product information and literature.

- ENA series network analyzers:  
  www.agilent.com/find/ena

- ENA series service and support:  
  http://www.agilent.com/find/ena_support

- Sample VBA Library for ENA Series:  
  http://www.agilent.com/find/enavba

- Balanced measurements:  
  www.agilent.com/find/balanced

- Electronic calibration (ECal) modules:  
  www.agilent.com/find/ecal

- Materials measurements:  
  www.agilent.com/find/materials

- Multiport test sets:  
  www.agilent.com/find/multiport

- Enhanced time domain analysis option:  
  www.agilent.com/find/ena-tdr

- Physical layer test systems:  
  www.agilent.com/find/plts

- PNA microwave network analyzers:  
  www.agilent.com/find/pna

- RF and microwave accessories:  
  www.agilent.com/find/accessories

- RF and microwave network analysis and impedance probings:  
  www.agilent.com/find/probingrf

- RF and microwave network analyzer calibration resources:  
  www.agilent.com/find/nacal

### Literature

ENA Series Data Sheet,  

ENA Series Configuration Guide,  

Network Analyzer Selection Guide,  

Test Solutions for Multiport and Balanced Devices Selection Guide,  
www.agilent.com
www.agilent.com/find/ena

For more information on Agilent Technologies’ products, applications or services, please contact your local Agilent office. The complete list is available at: www.agilent.com/find/contactus

**Americas**

<table>
<thead>
<tr>
<th>Country</th>
<th>Phone</th>
</tr>
</thead>
<tbody>
<tr>
<td>Canada</td>
<td>(877) 894 4414</td>
</tr>
<tr>
<td>Brazil</td>
<td>(11) 4197 3600</td>
</tr>
<tr>
<td>Mexico</td>
<td>01800 5064 800</td>
</tr>
<tr>
<td>United States</td>
<td>(800) 829 4444</td>
</tr>
</tbody>
</table>

**Asia Pacific**

<table>
<thead>
<tr>
<th>Country</th>
<th>Phone</th>
</tr>
</thead>
<tbody>
<tr>
<td>Australia</td>
<td>1 800 629 485</td>
</tr>
<tr>
<td>China</td>
<td>800 810 0189</td>
</tr>
<tr>
<td>Hong Kong</td>
<td>800 938 693</td>
</tr>
<tr>
<td>India</td>
<td>1 800 112 929</td>
</tr>
<tr>
<td>Japan</td>
<td>0120 (421) 345</td>
</tr>
<tr>
<td>Korea</td>
<td>080 769 0800</td>
</tr>
<tr>
<td>Malaysia</td>
<td>1 800 888 848</td>
</tr>
<tr>
<td>Singapore</td>
<td>1 800 375 8100</td>
</tr>
<tr>
<td>Taiwan</td>
<td>0800 047 866</td>
</tr>
<tr>
<td>Other AP Countries</td>
<td>(65) 375 8100</td>
</tr>
</tbody>
</table>

**Europe & Middle East**

<table>
<thead>
<tr>
<th>Country</th>
<th>Phone</th>
</tr>
</thead>
<tbody>
<tr>
<td>Belgium</td>
<td>32 (0) 2 404 93 40</td>
</tr>
<tr>
<td>Denmark</td>
<td>45 45 80 12 15</td>
</tr>
<tr>
<td>Finland</td>
<td>358 (0) 10 855 2100</td>
</tr>
<tr>
<td>France</td>
<td>0825 010 700*</td>
</tr>
<tr>
<td>Germany</td>
<td>49 (0) 7031 464 6333</td>
</tr>
<tr>
<td>Ireland</td>
<td>1890 924 204</td>
</tr>
<tr>
<td>Israel</td>
<td>972-3-9288-504/544</td>
</tr>
<tr>
<td>Italy</td>
<td>39 02 92 60 8484</td>
</tr>
<tr>
<td>Netherlands</td>
<td>31 (0) 20 547 2111</td>
</tr>
<tr>
<td>Spain</td>
<td>34 (91) 631 3300</td>
</tr>
<tr>
<td>Sweden</td>
<td>0200-88 22 55</td>
</tr>
<tr>
<td>United Kingdom</td>
<td>44 (0) 118 927 6201</td>
</tr>
</tbody>
</table>

*0.125 €/minute

*For other unlisted countries: www.agilent.com/find/contactus

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